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<b>Substitute for form 1449A/B/PTO</b>  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)			<b>Complete If Known:</b>		
			Application Number	10/777,020 - Conf. # 2206	
			Filing Date	February 10, 2004	
			First Named Inventor	Gregory B. Altshuler	
			Art Unit	3739	
			Examiner Name	Not Yet Assigned	
Sheet	1	of	3	Attorney Docket Number	105090-0234

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Examiner Signature	OH Jones			Date Considered	9/29/05